



ET3DV6 SN:1788

September 30, 2004

DASY - Parameters of Probe: ET3DV6 SN:1788

Sensitivity in Free Space ^A			Diode C	ompression ^B
NormX	1.68 ± 9.9%	μ V/(V/m) ²	DCP X	94 mV
NormY	1.70 ± 9.9%	$\mu V/(V/m)^2$	DCP Y	94 mV
NormZ 1.74 \pm 9.9% $\mu V/(V/m)^2$			DCP Z	94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz

MHz Typical SAR gradient: 5 % per mm

Sensor Cente	Sensor Center to Phantom Surface Distance		4.7 mm
SAR _{be} [%]	Without Correction Algorithm	8.1	4.4
SAR _{be} [%]	With Correction Algorithm	0.7	0.1

TSL

1810 MHz Typical SAR gradient: 10 % per mm

Sensor Cente	r to Phantom Surface Distance	3.7 mm 4.7 mm	
SAR _{be} [%]	Without Correction Algorithm	12.0 8.2	
SAR _{be} [%]	With Correction Algorithm	0.9 0.1	

Sensor Offset

Probe Tip to Sensor Center

2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).
^B Numerical linearization parameter: uncertainty not required.

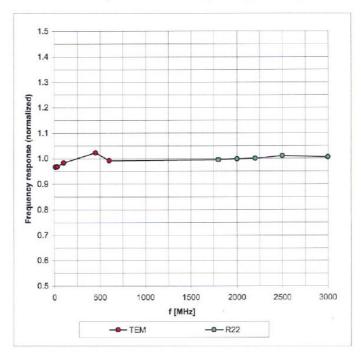
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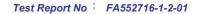
Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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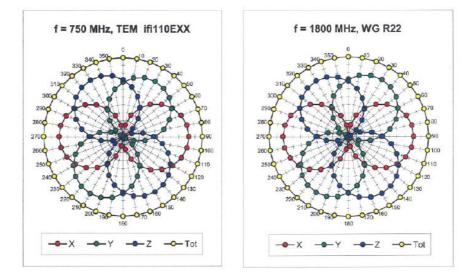
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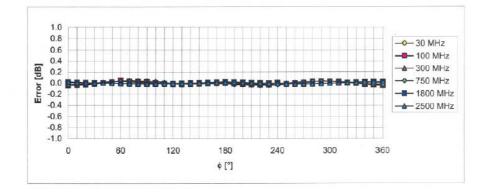


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Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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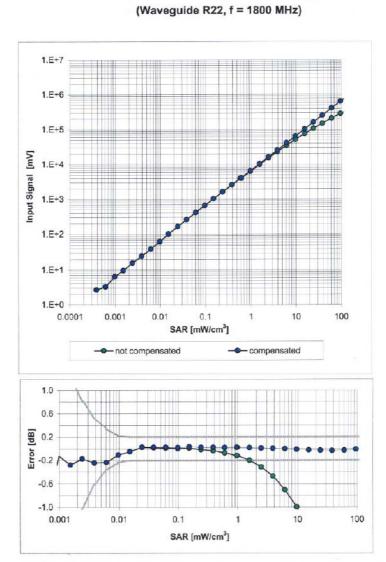
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Dynamic Range f(SAR_{head})

Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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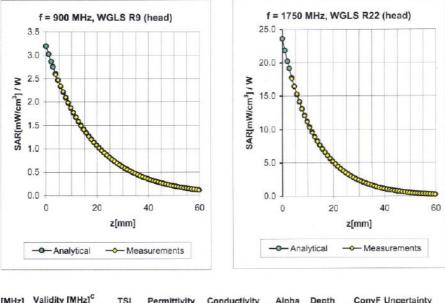
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Conversion Factor Assessment

f [MHz]	Validity [MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

^C The validity of ± 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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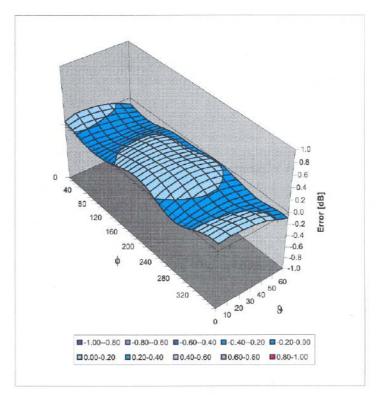


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Deviation from Isotropy in HSL

Error (\, \,), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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Chmid & Partner Engineering AG eughausstrasse 43, 8004 Zurich,	Of Switzerland		Service suisse d'étalonnage Servizio svizzero di taratura
ccredited by the Swiss Federal Off he Swiss Accreditation Service i Iultilateral Agreement for the rec	s one of the signatories	to the EA	n No.: SCS 108
lient Sporton (Auden))	Certificate N	lo: DAE3-577_Nov04
CALIBRATION CI	ERTIFICATE		
Dbject	DAE3 - SD 000 D	03 AA - SN: 577	
Calibration procedure(s)	QA CAL-06.v10 Calibration proceed	dure for the data acquisition uni	t (DAE)
Calibration date:	November 17, 20	04	
condition of the calibrated item	In Tolerance		
his calibration certificate document he measurements and the uncerta	ainties with confidence pro	anal standards, which realize the physical u obability are given on the following pages a	and are part of the certificate.
his calibration certificate documen he measurements and the uncerta Il calibrations have been conducte alibration Equipment used (M&TE	ainties with confidence produced in the closed laboratory critical for calibration)		ind are part of the certificate. °C and humidity < 70%.
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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle digital acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
- AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Reso	ution nominal			
High Range:	1LSB =	6.1µV,	full range =	-100+300 mV
Low Range:	1LSB =	61nV,	full range =	-1+3mV
DASY measurement p	arameters: Aut	o Zero Time: 3	sec; Measuring 1	time: 3 sec

Calibration Factors	x	Y	Z
High Range	404.437 ± 0.1% (k=2)	$403.891 \pm 0.1\%$ (k=2)	$404.359 \pm 0.1\%$ (k=2)
Low Range	3.94121 ± 0.7% (k=2)	3.89867 ± 0.7% (k=2)	3.95408 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	127 ° ± 1 °
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Appendix

1. DC Voltage Linearity

High Range	Input (µV)	Reading (µV)	Error (%)
Channel X + Input	200000	200000.6	0.00
Channel X + Input	20000	20001.77	0.01
Channel X - Input	20000	-19991.81	-0.04
Channel Y + Input	200000	199999.7	0.00
Channel Y + Input	20000	19999.20	0.00
Channel Y - Input	20000	-19994.82	-0.03
Channel Z + Input	200000	200000.2	0.00
Channel Z + Input	20000	19996.22	-0.02
Channel Z - Input	20000	-19996.74	-0.02

Low Range	Input (µV)	Reading (µV)	Error (%)
Channel X + Inpu	rt 2000	2000	0.00
Channel X + Inpu	rt 200	200.05	0.03
Channel X - Inpu	t 200	-200.88	0.44
Channel Y + Inpu	rt 2000	1999.9	0.00
Channel Y + Inpu	nt 200	199.73	-0.13
Channel Y - Inpu	t 200	-200.53	0.27
Channel Z + Inpu	rt 2000	2000.1	0.00
Channel Z + Inpu	nt 200	199.25	-0.38
Channel Z - Inpu	t 200	-201.42	0.71

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.15	12.30
	- 200	-12.61	-12.86
Channel Y	200	-7.43	-7.53
	- 200	6.30	6.52
Channel Z	200	-0.16	0.31
	- 200	-1.51	-1.48

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	1.90	-0.22
Channel Y	200	1.47	-	4.60
Channel Z	200	-1.40	-0.08	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15948	15814
Channel Y	15960	16073
Channel Z	16236	16172

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.03	-3.07	1.24	0.58
Channel Y	-0.66	-2.19	1.96	0.55
Channel Z	-0.91	-2.82	0.42	0.39

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	199.3
Channel Y	0.2000	200.4
Channel Z	0.2001	199.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V _{DC})
Channel X, Y, Z	+1.25

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